Search Notes

Application/Control	No.

Applicant(s)/Patent under Reexamination

10/038,961

Examiner

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Art Unit

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2617

SEARCHED				
Class	Subclass	Date	Examiner	
455	552.1	7/28/06	DÇL	
	553	1/1		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
Interfere	ne Search	7/28/06	DCL	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Inventor Name Search (Check for double patenting) EAST Search updating (EPU, JPO, DERWENT, US, USPUB)	7/28/06	DCL	
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